



600V, 20A, Trench FS II Fast IGBT

General Description:

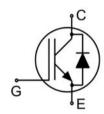
Using MJ's proprietary trench design and advanced FS (Field Stop) second generation technology, the 600V Trench FSII IGBT offers superior conduction and switching performances, and easy parallel operation;

Features

- ◆ Trench FSII Technology offering
- ♦ Very low VcE (sat)
- High speed switching
- ◆ Positive temperature coefficient in V_{CE} (sat)
- ◆ Very tight parameter distribution
- ♦ High ruggedness, temperature stable behavior

Application

- Air Condition
- Inverters
- ♠ Motor drives







TO-263

Package Marking and Ordering Information

Device	Device Package	Device Marking
MJ20TD60BD	TO-263	MJ20TD60BD

Absolute Maximum Ratings (Tc=25°C unless otherwise noted)

Parameter	Symbol	Value	Units	
Collector-Emitter Voltage	Vces	600	V	
Gate- Emitter Voltage	VGES	±30	V	
Collector Current	Ic	40	А	
Collector Current @Tc = 100 °C	Ic	20	А	
Pulsed Collector Current, tp limited by T _{jmax}	Cplus	60	А	
turn off safe operating area, VcE=600V, Tj=150°C	-	60	А	
Diode Continuous Forward Current @Tc = 100 °C	lF	20	А	
Diode Maximum Forward Current	lғм	60	Α	
Power Dissipation @ Tc = 25°C	Po	163	W	
Power Dissipation @Tc = 100 °C	Po	81.5	W	
Operating Junction and Storage Temperature Range	TJ,Tstg	-55 to +175	°C	
Maximum Temperature for Soldering	T∟	260	°C	
Short circuit withstand time V _{SE} =15.0V, V _{CC} ≤400V, Allowed number of short circuits<1000Time between short circuits:≥1.0s,Tj≤150°C	tsc	5	us	





Thermal Characteristic

Parameter	Symbol	Value	Units
Thermal Resistance, Junction to case for IGBT	Rejc	0.92	°C/W
Thermal Resistance, Junction to case for Diode	Rejc	1.92	°C/W
Thermal Resistance, Junction to Ambient	RөJA	62	°C/W

Electrical Characteristics (Tc=25°C unless otherwise noted)

Danamatan	Symbol	Total Conditions		Value			
Parameter	Symbol	rest Co	Test Conditions		Тур	Max	Units
Static Characteristics							
Collector-Emitter Breakdown Voltage	V(BR)CES	V _{GE} =0V,	Ice=1mA	600	-	-	V
Collector-Emitter Leakage Current	Ices	V _{GE} =0V,	/ce=600V	-	-	4	uA
Gate to Emitter Forward Leakage	IGES(F)	V _{GE} =+30	V,VcE=0V	-	-	100	nA
Gate to Source Reverse Leakage	IGES(R)	V _{GE} =-30	V,VcE=0V	-	-	100	nA
Collector-Emitter Saturation Voltage	VcE(sat)	Ic=20A Tj=25°C	-	1.7	1.9	V	
Collector-Efficiel Saturation voltage	V CE(sat)	V _{GE} =15V	Tj=100°C	-	1.9	-	V
Gate Threshold Voltage	V _{GE(th)}	Ic=1mA	Vce=Vge	4.0	-	6.0	V
Dynamic Characteristics							
Input Capacitance	Cies			-	2580	-	pF
Output Capacitance	Coss		/,V _{GE} =0V, MHz	-	48	-	pF
Reverse Transfer Capacitance	Crss	-		-	26	-	pF
Total Gate Charge	Qg			-	97	-	nC
Gate to Emitter Charge	Qge		V, Ic=20A =15V	-	17	-	nC
Gate to Collector Charge	Qgc	-		-	37	-	nC
Short circuit collector current Max.1000 short circuits Time between short circuits: ≥1.0s	Ic(sc)		Vcc≤400V, Tj≤150°C	-	130	-	А
Switching Characteristics							
Turn-on Delay Time	t _d (ON)			-	18	_	ns
Rise Time	tr			-	16	-	ns
Turn-Off Delay Time	t _{d(OFF)}	-		-	164	-	ns
Fall Time	tr	V _{GE} =0/15)V,Ic=10A V, R _g =25Ω ve Load	-	15	-	ns
Turn-On Switching Loss	Eon	. maucu	vo Luau	-	0.43	-	mJ
Turn-Off Switching Loss	Eoff	-		-	0.17	-	mJ
Total Switching Loss	Ets	-		_	0.60	_	mJ

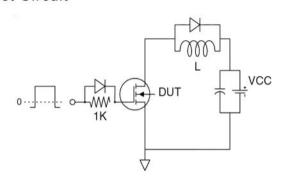




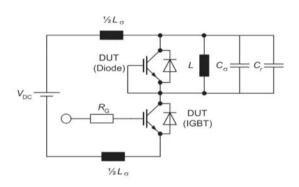
Electrical Characteristics of the Diode (Tc= 25°C unless otherwise specified):

Desembles	Symbol	Took Conditions	Rating		l laite	
Parameter	Symbol	Test Conditions	Min	Тур	Max	Units
Diode Forward Voltage	VFM	I=20A	-	1.45	1.7	V
Reverse Recovery Time	Trr		_	182	-	ns
Diode Peak Reverse Recovery Current	IRRM	I _F =20A,di/dt=200A/uS	_	5.3	-	А
Reverse Recovery Charge	Qrr	-	_	0.5	-	uC
Pulse width ttp≤380μs,δ≤2%				1		

Test Circuit

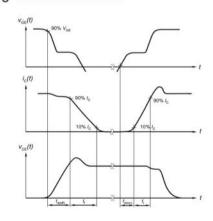


Gate Charge Test Circuit

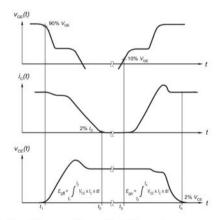


Switch Time Test Circuit

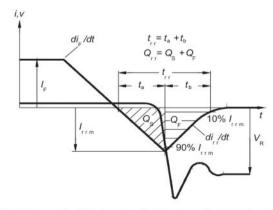
Switching characteristics



definition of switching times



definition of switching losses

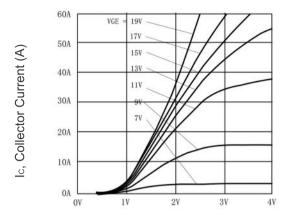


Definition of diode switching characteristics



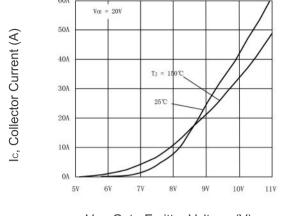


Typical Electrical and Thermal Characteristics

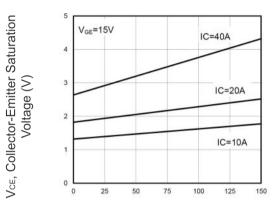


Vce, Collector-Emitter Voltage (V)

Figure 1 Output Characteristics



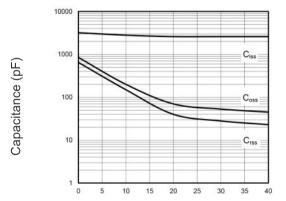
V_{GE}, Gate-Emitter Voltage (V) Figure 2 Transfer Characteristics



T_J, Junction Temperature (°C) Figure 3 VcEsat vs. Case Temperature

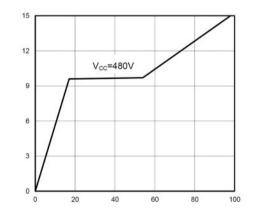
32 VCE, Collector-Emitter Saturation 24 40A 16 10A 20A 12

VGE, Gate-Emitter Voltage (V) Figure 4 Saturation Voltage vs. VgE



Vce, Collector-Emitter Voltage (V)

Figure 5 Capacitance Characteristics



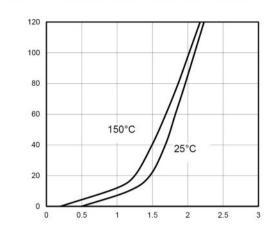
QG, Total Gate Charge (nC) Figure 6 Gate charge waveform

VGE, Gate-Emitter Voltage (V)

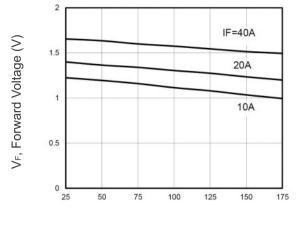
IF, Forward Current (A)

Ic, Collector Current (A)

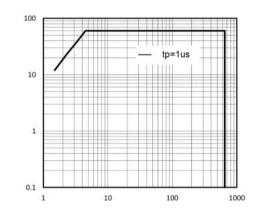
Typical Electrical and Thermal Characteristics (continued)



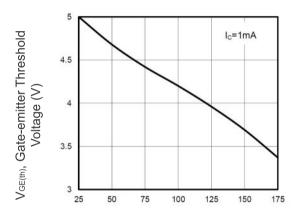
V_F, Forward Voltage (V)
Figure 7 Forward Characteristics



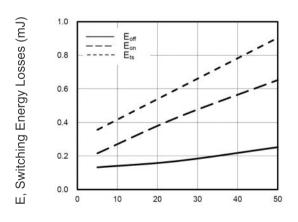
TJ, Junction Temperature (°C)
Figure 8 VF vs. Temperature



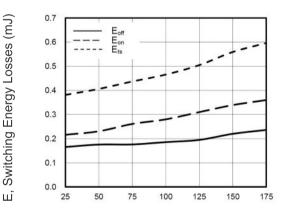
Vce, Collector-Emitter Voltage (V)
Figure 9 Forward Bias Safe Operating



TJ, Junction Temperature (°C)
Figure 10 Gate-emitter Threshold Voltage as a Function of Junction Temperature



 ${\sf R}_{\sf G}, \, {\sf Gate \ Resistor} \, (\Omega)$ Figure 11 Typical Switching Times as a Function of Gate Resistor



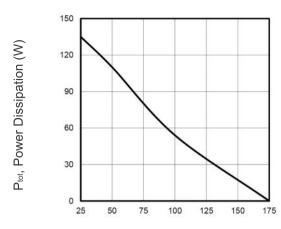
TJ, Junction Temperature (°C)
Figure 12 Typical Switching Times as a
Function of Junction Temperature



Vce, Collector-Emitter Voltage (V)



Typical Electrical and Thermal Characteristics (continued)



Tc, Case Temperature (°C)

Figure 13 Power Dissipation as a Function of Case Temperature

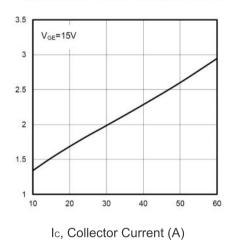
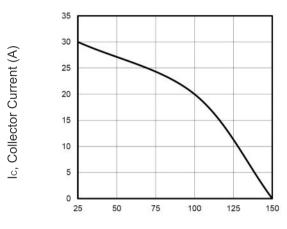


Figure 15 Typical Collector-emitter Saturation Voltage as a function of Collector Current

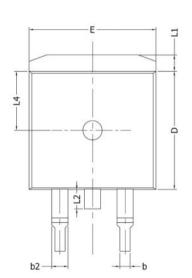


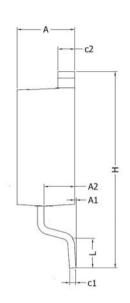
Tc, Collector-Emitter Case Temperature (°C)
Figure 14 Current Derating

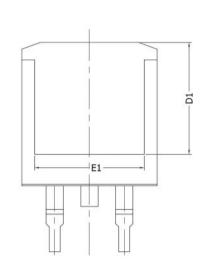




TO-263-3L Package Information







Symbol	Dimensions In Millimeters		Dimensions In Inches		
Symbol	Min.	Max.	Min.	Max.	
Α	4.40	4.60	0.17	0.18	
A1	0.00	0.25	0.00	0.01	
A2	2.20	2.60	0.09	0.10	
b	0.76	0.89	0.03	0.04	
b2	1.23	1.37	0.04	0.05	
С	0.47	0.60	0.01	0.02	
c1	0.46	0.56	0.18	0.02	
c2	1.25	1.35	0.05	0.05	
D	9.10	9.30	0.35	0.36	
D1	8.00	-	0.31	-	
E	9.80	10.00	0.38	0.39	
E1	7.80	72	0.31	72	
е	2.54	BSC	0.10	BSC	
Н	14.90	15.70	0.59	0.62	
L	2.00	2.60	0.08	0.10	
L1	1.17	1.40	0.05	0.06	
L2	-	1.75	<u> </u>	0.07	
L4	4.60	REF	0.18REF		





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